

## Laboratory Instruments Available to Support Spa Station Researchers at Marshall Space Flight Cer by Dr. Binayak Panda and Dr. Sridhar Gorti Materials and Processes Laboratory, NASA Marshall Space Flight Center

## Abstract

A number of research instruments are available at NASA's Marshall Space Flight Center (MSFC) A number of research instruments are available at NASA's Marshall Space Flight Center (MSFC) to support 1SS researchers and their investigations. These modern analytical tools yield valuable and sometimes new informative resulting from sample characterization. Instruments include modern scanning electron microscopes equipped with field emission guns providing analytical capabilities that include angstrom-level image resolution of dry, wet and biological samples. These microscopes are also equipped with silicen ordiff X-ray detectors (SDI) for fast yet precise analytical mapping of phases, as well as electron back-scattered diffraction (EBSD) publis to ever a cross accessible services and the services and the services of the services of the services and the services are serviced to the services are serviced to the services and the services are serviced to the services are serviced to the services and the services are serviced to the services are serviced to the services and the services are serviced to the services and the services are serviced to the services and the services are serviced to the services are serviced to the services are serviced to the services and the services are serviced to the services are serviced to the services and the services are serviced to the services are serviced to the services are serviced to the services and the services are serviced to the services and the services are serviced to units to map grain orientations in crystalline alloys. Sample chambers admit large samples, provide variable pressures for wet samples, and quantitative analysis software to determine

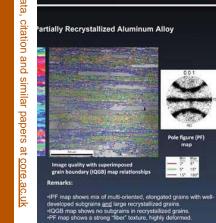
phase relations.

Advances in solid-state electronics have also facilitated improvements for surface chemical analysis that are successfully employed to analyze metallic materials and alloys, ceramics, slaps, and organic polymers. Another analytical capability at MSFC is a magnetic sector Secondary Ion Mass Spectorscopy (SIMS) that quantitatively determines and maps light elements such as hydrogen, lithium, and boron along with their isotopes, identifies and quantifies very low level impurities even at parts per billion (ppb) levels. Still other methods quantities very low inveil impurities even at parts per ciliion (ppo) leveis. Still other methods available at MSFC include X-ray photo-electron spectorscopy (XPS) that can determine oxidation states of elements as well as identify polymers and measure film thicknesses on coated materials, Scanning Auger electron spectorscopy (SAM) which combines surface sensitivity, spatial lateral resolution (~20 nm), and depth profiling capabilities to describe elemental compositions in ears surface regions and even the chemical state of analyzed atoms.

Conventional Transmission Electron Microscope (TEM) for observing internal microstructures at very high magnifications and the Electron Probe Micro-analyzer (EPMA) for very precise microanalysis are available as needed by the researcher. Space Station researchers are invited to work with MSFC in analyzing their samples using these techniques.







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JEOL Superprobe(JXA-8900R): Scanning Microprobe allows for precise chemical analysis down to ppm levels using xrays. Uses four spectrometers with a large chamber size that can accommodate either fractured or flat samples

